

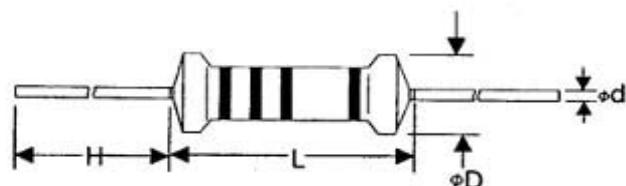
Metal Glaze Fixed Resistors



Performance Specification

Characteristics	Test Methods	Limits																				
Temperature Coefficient JIS-C-5202 5.2	<p>Natural resistance change per temp degree centigrade $\frac{R_2 - R_1}{R_1(t_2-t_1)} \times 10^{-3} \text{ (PPM / } ^\circ\text{C)}$</p> <p>R1:Resistance value at room temperature (t 1) R2:Resistance value at room tem. Plus 100 °C (t 2)</p>	±200 PPM / °C Max.																				
Short time overload JIS-C-5202 5.5	Permanent resistance change after the application of a potential of 2.5 times RCWV for 5 seconds.	Resistance change rate is ±(1%+0.05Ω) With no evidence of mechanical damage.																				
Dielectric withstanding Voltage JIS-C-5202 5.7	Resistors Shall be clamped in the through of a 90° Metallic V-block and shall be tested at AC potential respectively specified in the table 1. For 60 +10/-0 seconds.	No evidence of flashover mechanical damage, arcing or insulation break down.																				
Pulse overload JIS-C-5202 5.8	Resistance change after 10,000 cycles (1 second "On", 25 Seconds "off") at 4 time RCWV or the max. pulse overload voltage.	Resistance change rate is ±(2%+0.05Ω) With no evidence of mechanical damage.																				
Temperature cycling JIS-C-5202 7.4	<p>Resistance change after continuous 5 cycles for duty shown below:</p> <table border="1"> <thead> <tr> <th>Step</th> <th>Temperature</th> <th>Time</th> </tr> </thead> <tbody> <tr> <td>1</td> <td>- 55 ±3</td> <td>30 minutes</td> </tr> <tr> <td>2</td> <td>Room temp.</td> <td>10~15 minutes</td> </tr> <tr> <td>3</td> <td>+ 55 ±2</td> <td>30 minutes</td> </tr> <tr> <td>4</td> <td>Room temp.</td> <td>10~15 minutes</td> </tr> </tbody> </table>	Step	Temperature	Time	1	- 55 ±3	30 minutes	2	Room temp.	10~15 minutes	3	+ 55 ±2	30 minutes	4	Room temp.	10~15 minutes	Resistance change rate is ±(1% +0.05Ω) With no evidence of mechanical damage.					
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Load life in humidity JIS-C-5202 7.9	Resistance change after 1,000 hours (1.5hours "On", 0.5" hour "off") at RCWV in a humidity test chamber controlled at 40°C ±2°C and 90 to 95% relative humidity.	Resistance change rate is ±(5% +0.05Ω) With no evidence of mechanical damage.																				
Load life JIS-C-5202 7.10	Permanent resistance change after 1,000 hours operating at RCWV with duty cycle of (1.5hours "On", 0.5" hour "off") at 70°C ±2°C ambient.	Resistance change rate is ±(5% +0.05Ω) With no evidence of mechanical damage.																				
Terminal strength JIS-C-5202 6.1	<p>Direct load : Resistance to a 2.5 kgs direct load for 10 seconds in the direction of the Longitudinal axis of the terminal leads.</p> <p>Twist test: Terminal leads shall be bent through 90° at a point of about 6 mm from the Body of the resistor and shall be rotated through 360° about the original axis of the bent terminal in alternating direction for a total of 3 rotations.</p>	No evidence of mechanical damage																				
Resistance to soldering head JIS-C-5202 6.4	Permanent resistance change when leads immersed to 3.2 to 4.8 mm from The body in 350°C ±10°C solder for 3 ±0.5 seconds.	Resistance change rate is ±(1%+0.05Ω) With no evidence of mechanical damage.																				
Solderability JIS-C-5202 6.5	The area covered with a new ,smooth,clean,shiny, and continuous continuous surface free from concentrated pinholes. Test temp of solder: 235°C ±5°C. Dwell time in solder: 3 +0.5/-0 seconds.	95% coverage Min.																				
Surge Withstanding Voltage	<p>The following discharge cycle is repeated in the circuit in the left fig. 2.5 sec. ON, 2.5 sec. OFF, 10 cycles.</p> <p>Applied Voltage (DC Source):</p> <table border="1"> <thead> <tr> <th></th> <th>1/4W</th> <th>1/2W</th> <th>1 W</th> <th>2 W</th> </tr> </thead> <tbody> <tr> <td>100K~1M</td> <td>3000V</td> <td>4000V</td> <td>5000V</td> <td>8000V</td> </tr> <tr> <td>1.1M~6.2M</td> <td>4000V</td> <td>5000V</td> <td>6000V</td> <td>9000V</td> </tr> <tr> <td>>6.8M</td> <td>6000V</td> <td>6000V</td> <td>9000V</td> <td>10000V</td> </tr> </tbody> </table>		1/4W	1/2W	1 W	2 W	100K~1M	3000V	4000V	5000V	8000V	1.1M~6.2M	4000V	5000V	6000V	9000V	>6.8M	6000V	6000V	9000V	10000V	Allowable resistance change ±10%. Test circuit:
	1/4W	1/2W	1 W	2 W																		
100K~1M	3000V	4000V	5000V	8000V																		
1.1M~6.2M	4000V	5000V	6000V	9000V																		
>6.8M	6000V	6000V	9000V	10000V																		

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Dimension:

Part No.	Style	Power Rating at 70°C	Dimension (mm)			
			D Max	L Max	$d \pm 0.05$	H ± 3
MG25	MG1/4W	0.25 W	2.7	7.00	0.6	28
MG50	MG1/2W	0.50 W	3.8	10.0	0.6	28
MG100	MG 1 W	1.00 W	5.2	13.0	0.7	28
MG200	MG 2 W	2.00 W	6.0	17.0	0.8	28

Rating

Style	Max. working voltage	Max. Overload voltage	Dielectric Withstanding voltage	Surge withstandng voltage			Resistance range
				<1MΩ	1.1MΩ~6.2MΩ	>6.8MΩ	
MG 1/4W	500V	700V	500V	3000V	4000V	6000V	100KΩ~33MΩ
MG 1/2W	700V	1000V	700V	4000V	5000V	8000V	100KΩ~33MΩ
MG 1 W	1000V	1400V	1000V	5000V	6000V	9000V	100KΩ~33MΩ
MG 2 W	1000V	1400V	1000V	8000V	9000V	10000V	100KΩ~33MΩ

Derating Curve:

